Search Notes									

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/021,000	TAKESHITA, NOBUO	
Examiner	Art Unit	
Kim-Kwok CHU	2627	

	CEAD	CHED	
	SEAR	CHED	
Class	Subclass	Date	Examiner
369	53.19	5/13/2007	кс
369	44.22	5/13/2007	кс
369	44.16	5/13/2007	кс
369	244.1	5/13/2007	кс
369	269	5/13/2007	кс
310	90	5/13/2007	кс
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INT	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			
	<u> </u>					

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
East Search Updated	5/13/2007	кс	